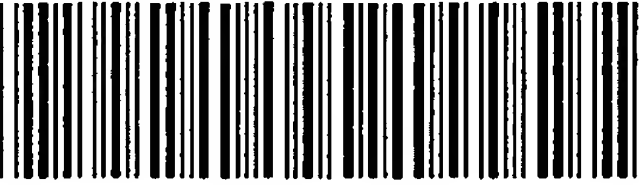


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/624,680	OTSUKI, TETSUYA	
	Examiner	Art Unit	
	Long K. Tran	2818	

SEARCHED			
Class	Subclass	Date	Examiner
257	698	1/12/2006	LKT

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
257/680,686,687,700,730,748,750,758,777 (text search only, see search history printout)	1/12/2006	LKT